Description

Features

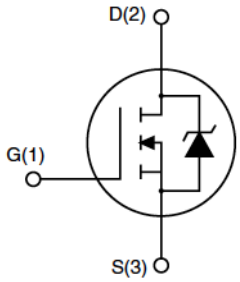
- 100V, 57A
- $R_{DS(ON)}$ =21mΩ (Typ.) @ V_{GS} = 10V, I_D =28.5A
- Fast Switching
- Improved dv/dt Capability
- 100% Avalanche Tested

Application

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply(UPS)
- Power Factor Correction (PFC)

TO-220C

TO-263



Schematic Diagram

Absolute Maximum Ratings (T_C=25℃ unless otherwise specified)

Symbol	Parameter		Max.	Units
			TO-220C/TO-263	
V_{DSS}	Drain-Source Voltage		100	V
V_{GSS}	Gate-Source Voltage		±20	V
I_D	Continuous Drain Current	T_C = 25℃	57	A
		T_C = 100℃	35	A
I_{DM}	Pulsed Drain Current note1		228	A
E_{AS}	Single Pulsed Avalanche Energy note2		605	mJ
P_D	Power Dissipation	T_C = 25℃	169	W
$R_{\theta JC}$	Thermal Resistance, Junction to Case		0.74	℃/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient		62.5	℃/W
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	℃

Electrical Characteristics (T_C=25℃ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
Off Characteristic						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	V_{GS}=0V,I_D=250μA	100	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 100V, V_{GS} = 0V, T_J= 25℃	-	-	1	μA
I_{GSS}	Gate to Body Leakage Current	V_{DS} =0V, V_{GS} = ±20V	-	-	±100	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}= V_{GS}, I_D=250μA	2	3	4	V
$R_{DS(on)}$	Static Drain-Source on-Resistance note3	V_{GS} =10V, I_D =28.5A	-	21	25	mΩ
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 25V, V_{GS} = 0V, f = 1.0MHz	-	3140	-	pF
C_{oss}	Output Capacitance		-	360	-	pF
C_{rss}	Reverse Transfer Capacitance		-	140	-	pF
Q_g	Total Gate Charge	V_{DD} = 80V, I_D = 57A, V_{GS} = 10V	-	126	-	nC
Q_{gs}	Gate-Source Charge		-	10	-	nC
Q_{gd}	Gate-Drain(“Miller”) Charge		-	36	-	nC
Switching Characteristics						
$t_{d(on)}$	Turn-on Delay Time	V_{DD} = 50V, I_D = 57A, R_G = 25Ω	-	35	-	ns
t_r	Turn-on Rise Time		-	60	-	ns
$t_{d(off)}$	Turn-off Delay Time		-	101	-	ns
t_f	Turn-off Fall Time		-	95	-	ns
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain to Source Diode Forward Current		-	-	57	A
I_{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	228	A
V_{SD}	Drain to Source Diode Forward Voltage	V_{GS} = 0V, I_{SD} =57A	-	-	1.4	V
t_{rr}	Reverse Recovery Time	V_{GS} =0V, I_S=57A, di/dt=100A/μs	-	250	-	ns
Q_{rr}	Reverse Recovery Charge		-	2	-	μC

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

2. V_{DD} = 50V, R_G = 25 Ω, Starting T_J = 25°C

3. Pulse Test: Pulse Width≤300μs, Duty Cycle≤1%

Typical Performance Characteristics

Figure1: Output Characteristics

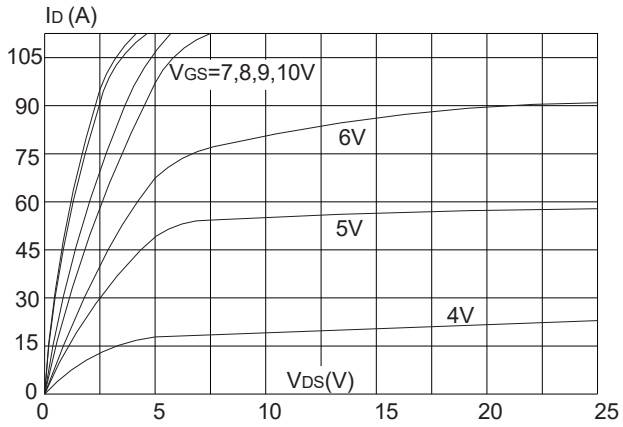


Figure 2: Typical Transfer Characteristics

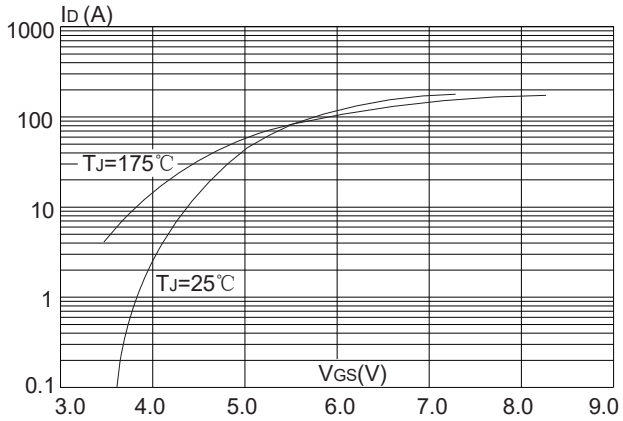


Figure 3: On-resistance vs. Drain Current

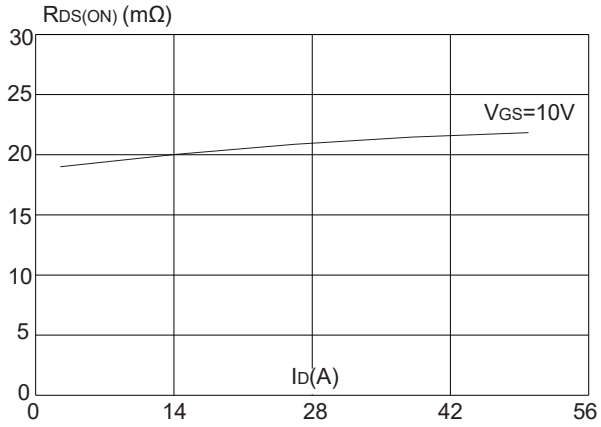


Figure 4: Body Diode Characteristics

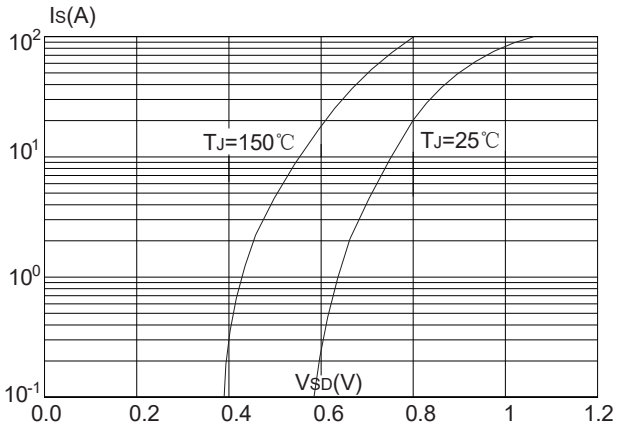


Figure 5: Gate Charge Characteristics

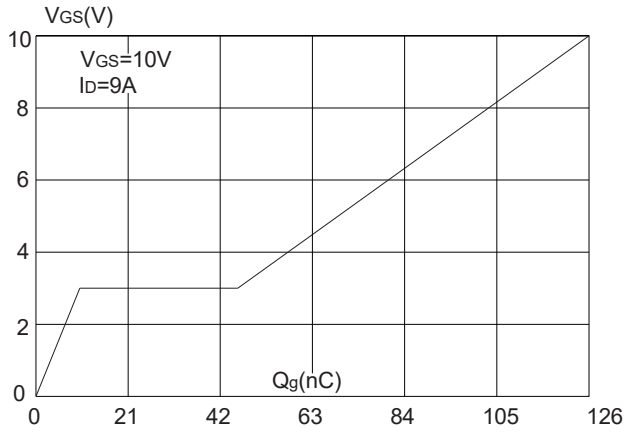


Figure 6: Capacitance Characteristics

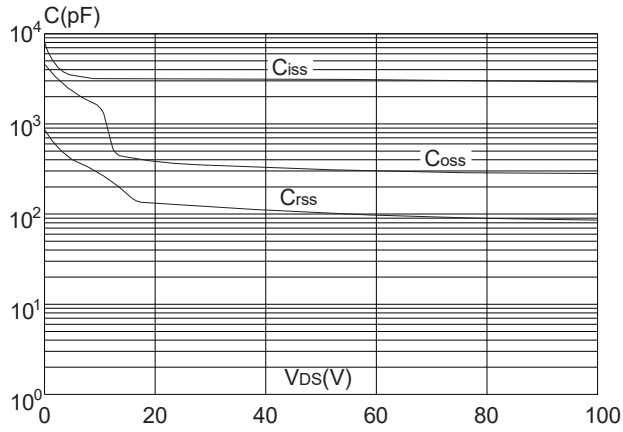


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

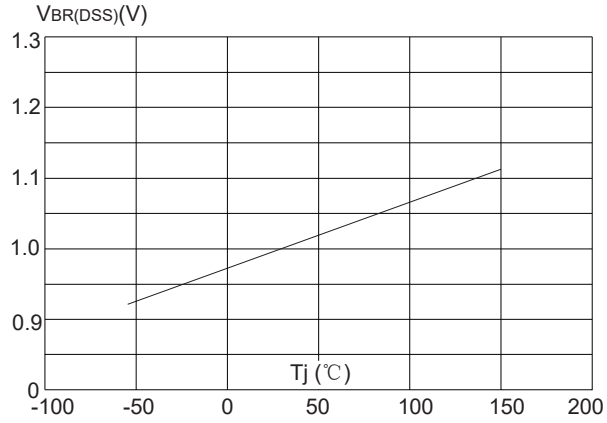


Figure 8: Normalized on Resistance vs. Junction Temperature

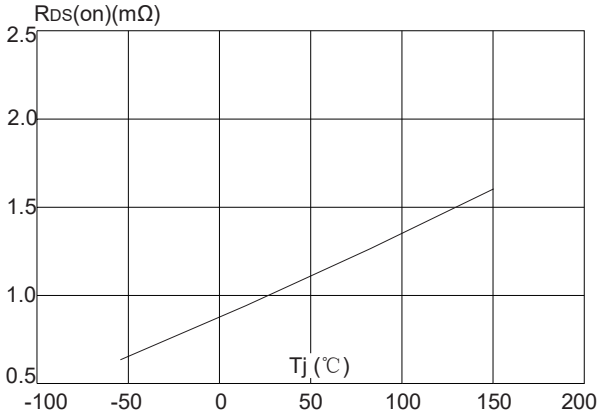


Figure 9: Maximum Safe Operating Area

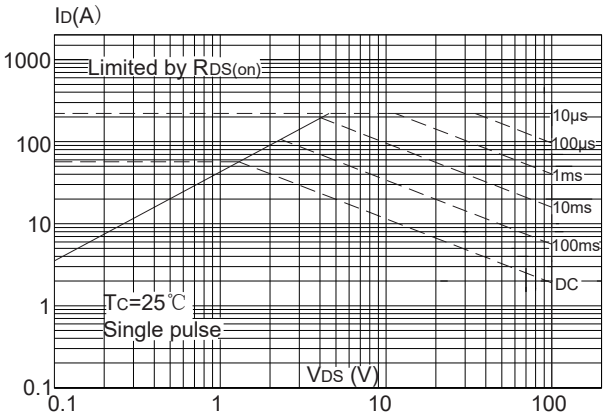


Figure 10: Maximum Continuous Drain Current vs. Case Temperature

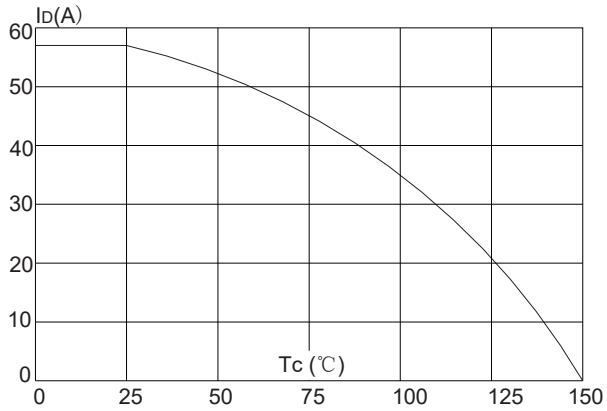
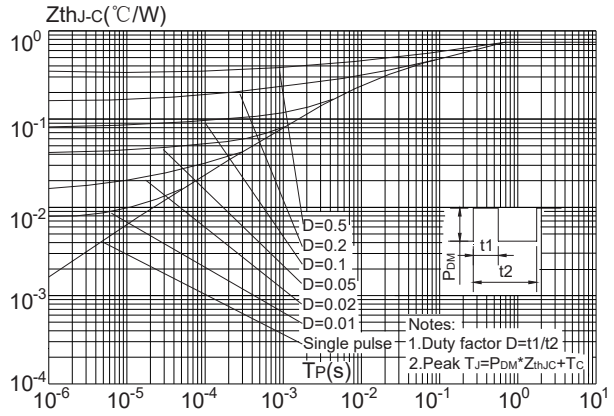


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case (TO-220C,TO-263)



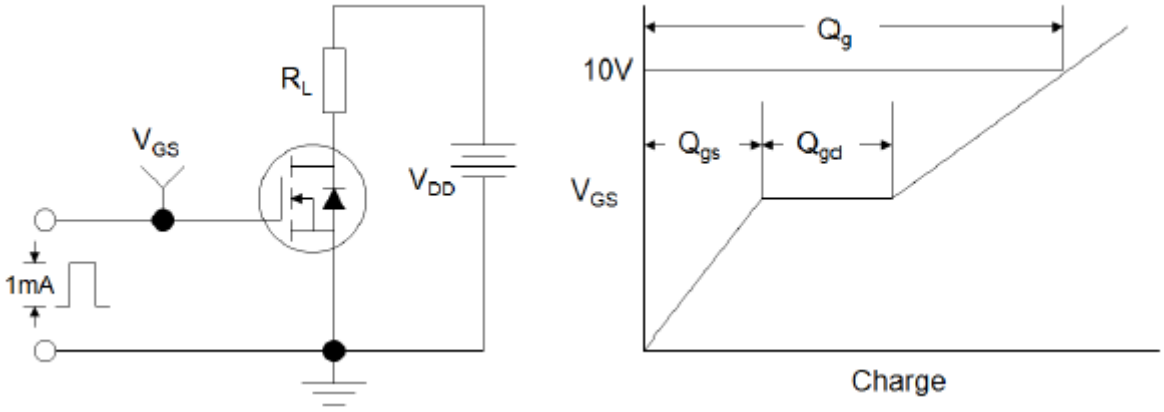


Figure1:Gate Charge Test Circuit & Waveform

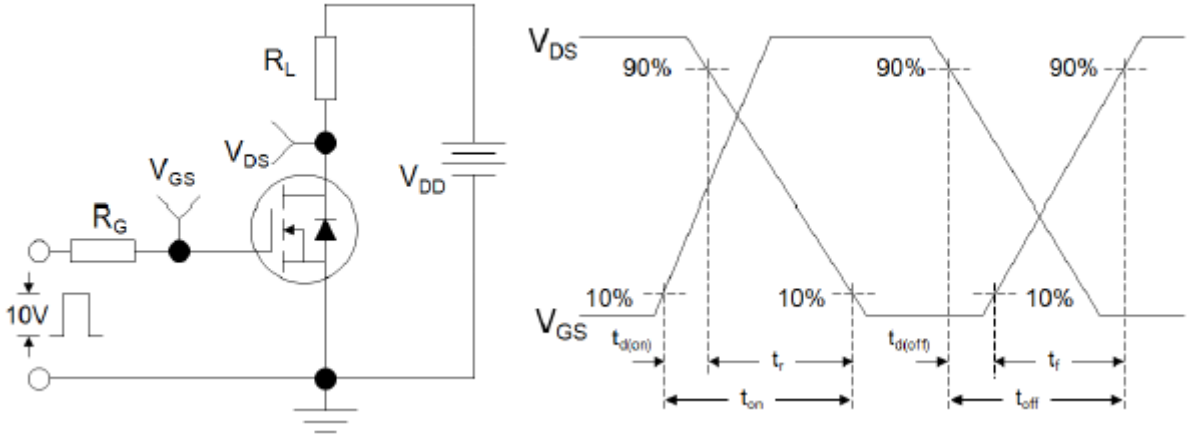


Figure 2: Resistive Switching Test Circuit & Waveforms

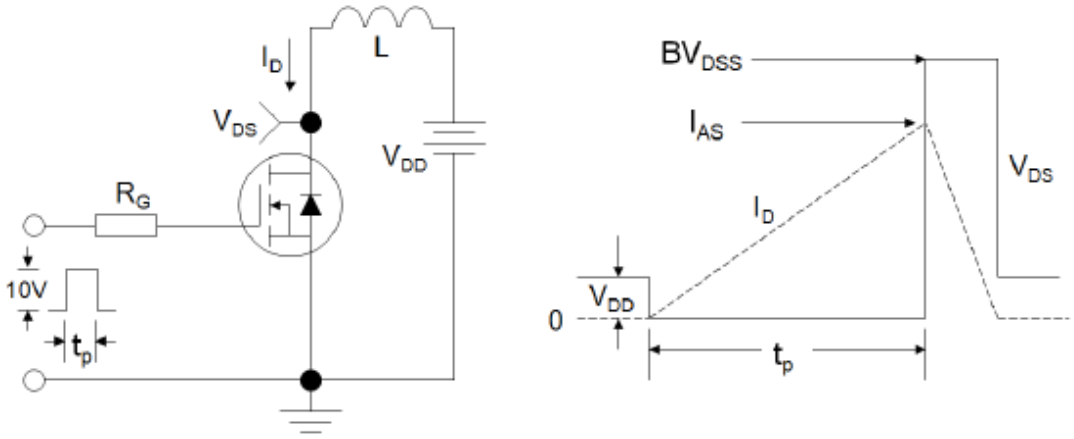


Figure 3:Unclamped Inductive Switching Test Circuit & Waveforms

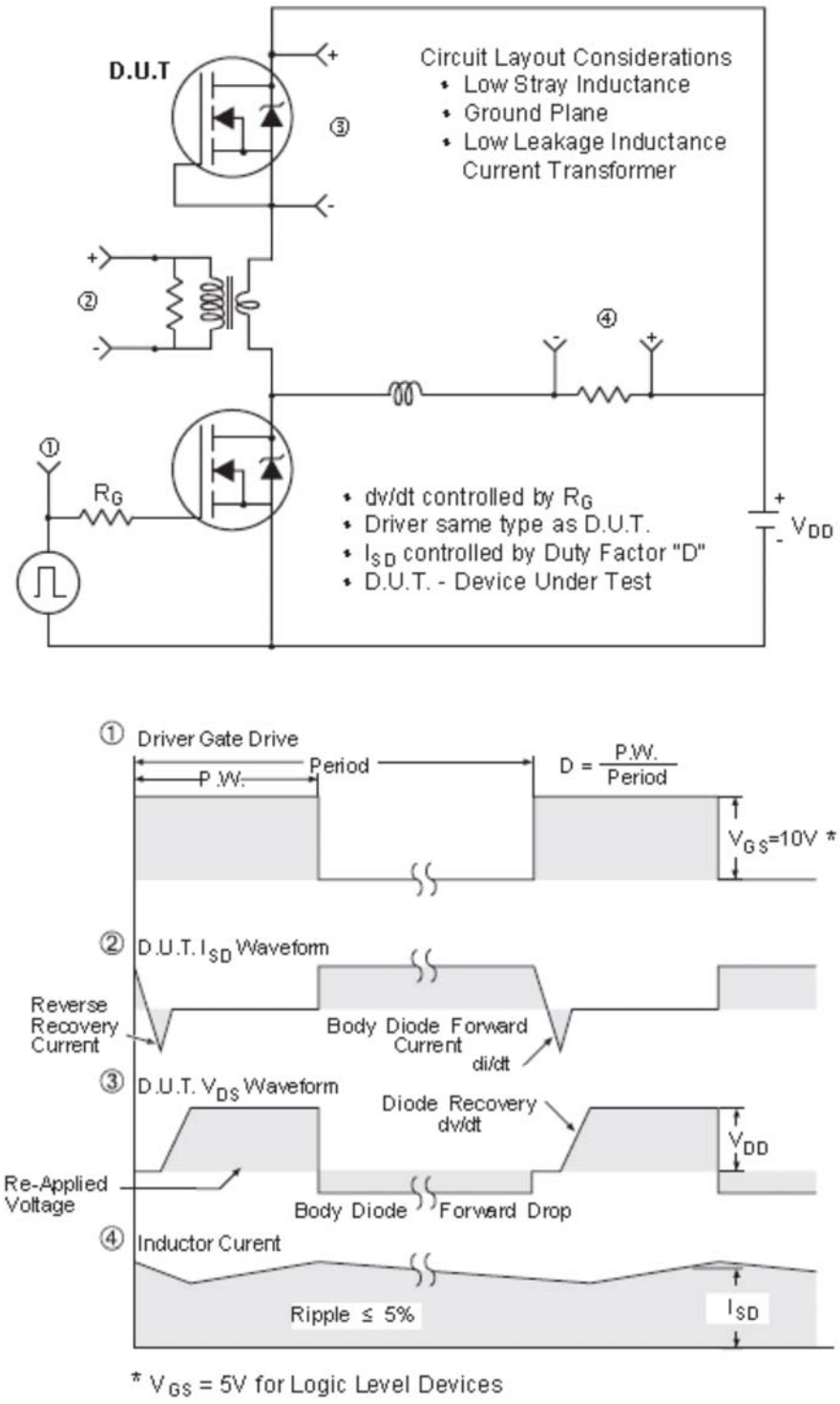


Figure 4:Peak Diode Recovery dv/dt Test Circuit & Waveforms (For N-channel)